

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/027,344	KENNEDY, HAMISH ALEXANDER	
	Examiner	Art Unit	Page 1 of 1
	Patrick J. Lee	2878	

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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